

09/845297  
05/01/01

355	68	Subclass
ISSUE CLASSIFICATIO		

## U.S. UTILITY Patent Application

M.S.	O.I.P.E.	PATENT DATE
SCANNED	KC <sup>3/2</sup> Q.A. <i>[Signature]</i>	

APPLICATION NO. 09/845297	CONT/PRIOR F	CLASS 355	SUBCLASS 5068	ART UNIT 2851	EXAMINER Alan Mattina
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Projection exposure apparatus having aberration measurement device

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ISSUING CLASSIFICATION											
ORIGINAL				CROSS REFERENCE(S)							
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
355		68		355	53	67					
INTERNATIONAL CLASSIFICATION											
G03B		27/74									
G03B		27/54									
G03B		27/42									

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<input type="checkbox"/> <b>TERMINAL DISCLAIMER</b>	<b>DRAWINGS</b>			<b>CLAIMS ALLOWED</b>	
	Sheets Drwg.	Figs. Drwg.	Print Fig.	Total Claims	Print Claim for O.G.
<input type="checkbox"/> The term of this patent subsequent to _____ (date) has been disclaimed.	_____ (Assistant Examiner) _____ (Date)			<b>NOTICE OF ALLOWANCE MAILED</b>	
<input type="checkbox"/> The term of this patent shall not extend beyond the expiration date of U.S. Patent. No. _____ _____ _____	_____ (Primary Examiner) _____ (Date)			<b>ISSUE FEE</b>	
				Amount Due	Date Paid
<input type="checkbox"/> The terminal _____ months of this patent have been disclaimed.	_____ (Legal Instruments Examiner) _____ (Date)			<b>ISSUE BATCH NUMBER</b>	

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